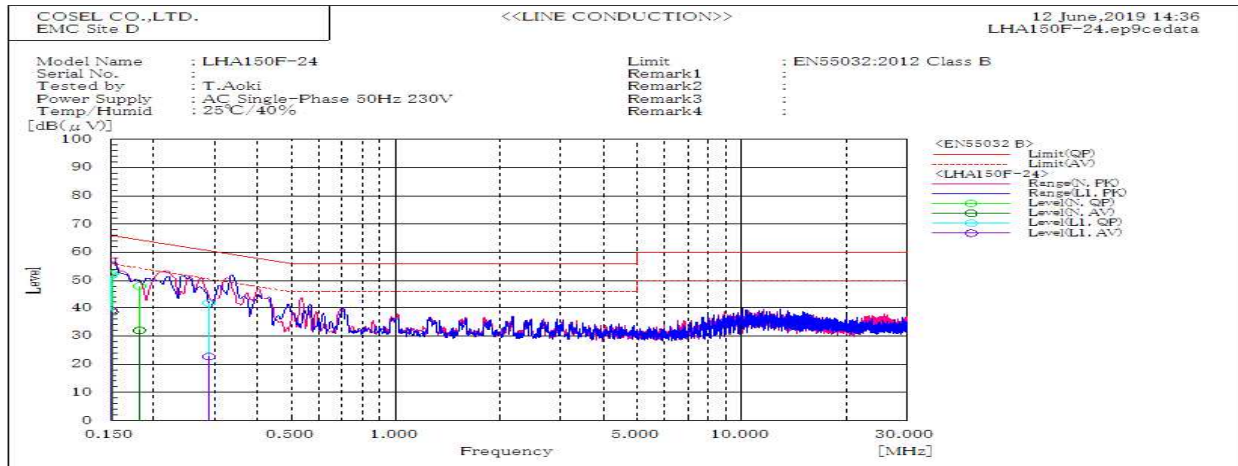
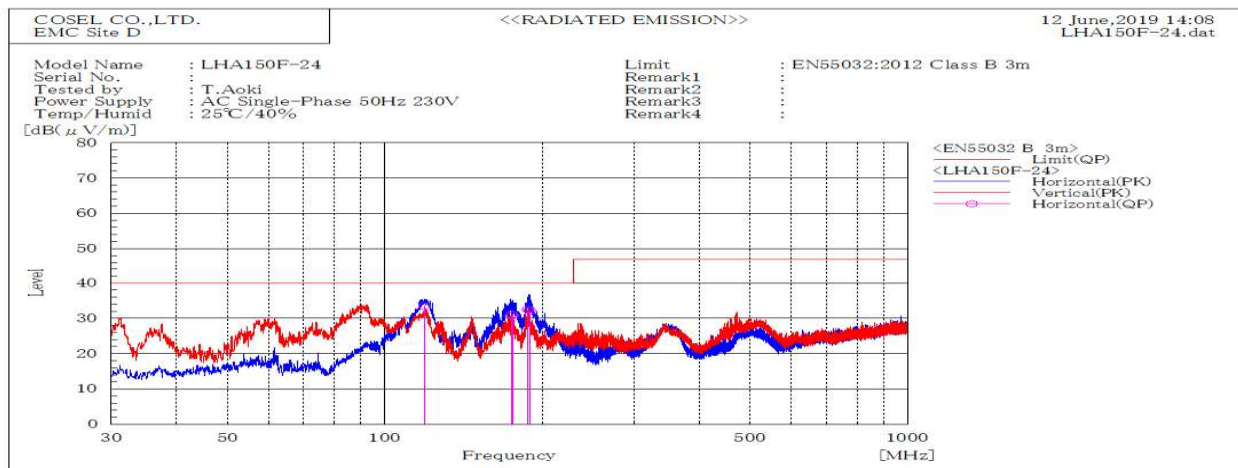


DATA SHEET		Date	12-Sep-19
Model	LHA150F-24	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	T.Aoki



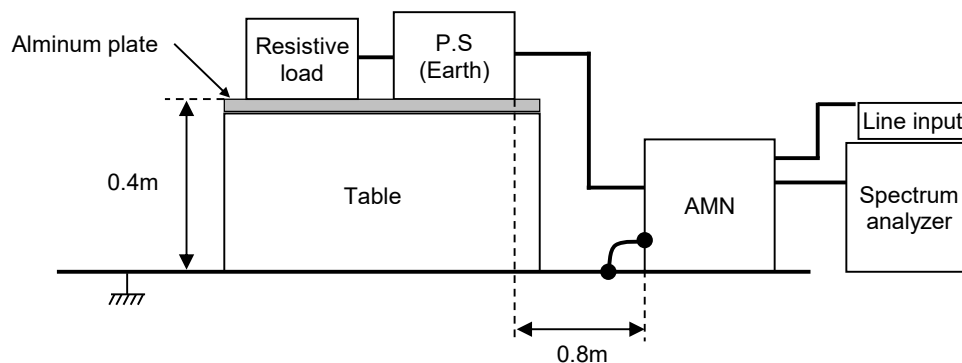
Frequency MHz	Line	Level dB(μV)		Limit dB(μV)		Margin dB		Pass/Fail	Remark
		QP	AV	QP	AV	QP	AV		
0.152	N	52.5	38.5	65.9	55.9	13.4	17.4	Pass	
0.182	N	48	32	64.4	54.4	16.4	22.4	Pass	
0.151	L1	51.9	39.1	66	56	14.1	16.9	Pass	
0.289	L1	41.7	22.7	60.6	50.6	18.9	27.9	Pass	



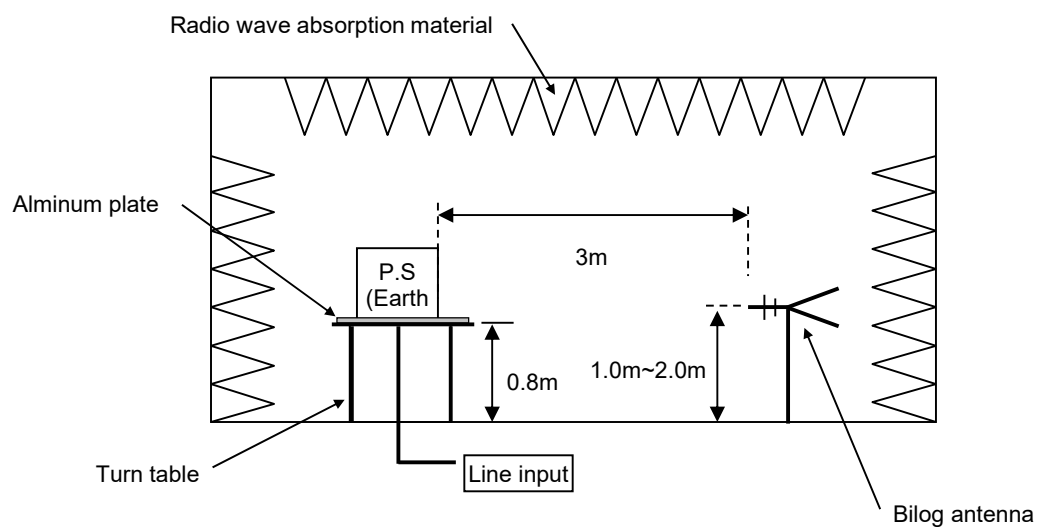
Frequency MHz	Polarization	Stability	Level dB(μV/m)	Limit dB(μV/m)	Margin dB	Pass/Fail	Height cm	Angle deg	Remark
			QP	QP	QP				
118.954	H	Stable	33.5	40	6.5	Pass	200	13.3	
174.941	H	Stable	31	40	9	Pass	200	16.1	
175.818	H	Stable	30.8	40	9.2	Pass	200	15.8	
187.942	H	Stable	32.4	40	7.6	Pass	198.5	2.9	
189.424	H	Stable	32.1	40	7.9	Pass	198.4	341.2	

DATA SHEET		Date	12-Sep-19
Model	Circuit used for measurement	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	T.Aoki

1. Line conduction



2. Radiated emission

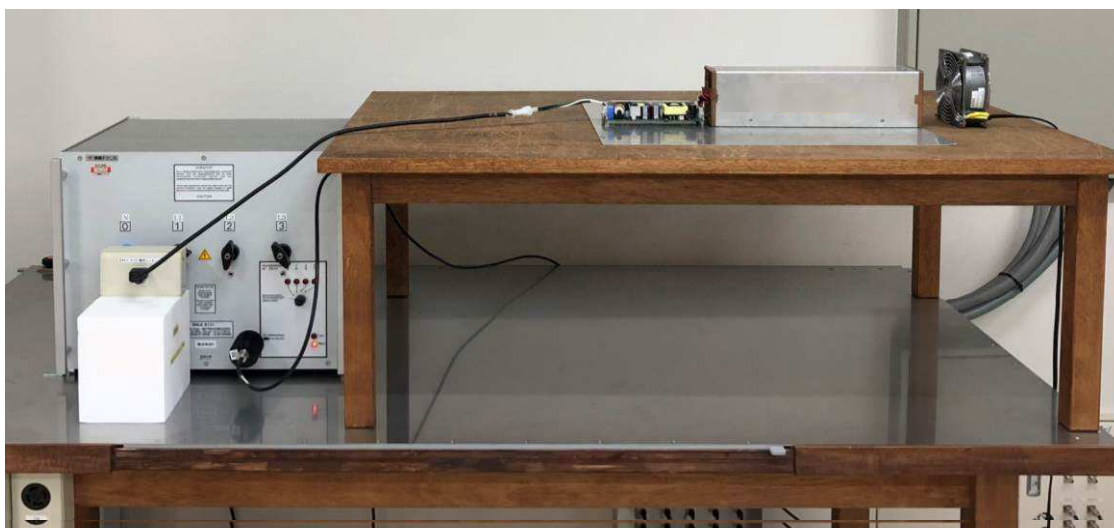


Conditions

Test : EMI
Model Name : LHA150F-24

Photographs of test set-up

1.LINE CONDUCTION



2.RADIATED EMISSION

